

Transition radiation PID with GaAs:Cr Timepix3

not silicon finally

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TR radiator basics

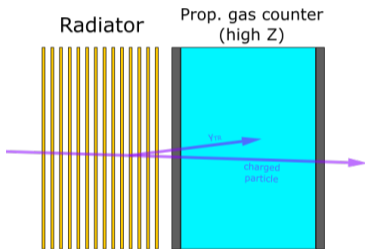


Figure: Typical TR setup

Photon energies: $E_\gamma \sim \gamma \bar{h}\omega_p \sim 10 \text{ keV}$

Yield: approx. 1 TR photon per particle
(for a 100-foil radiator)

Gamma factor range: $\gamma \in [10^3 \div 10^4]$

Interference due to structure periodicity:

- > Radiation is suppressed for charged particles slower than a certain γ_{thr}
- > Angular spectrum oscillates

Conventional TR particle identification

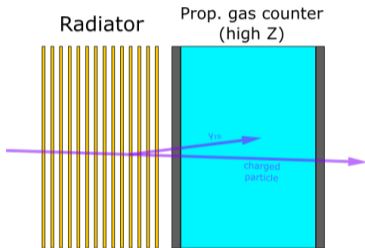


Figure: Typical TR setup

«Slow» particle, $\gamma < \gamma_{thr}$, e.g. muon

Expected energy deposit:
charged particle dE/dX (10 keV)

«Fast» particle, $\gamma > \gamma_{thr}$, e.g. electron

Expected energy deposit:
charged particle dE/dX (10 keV) +
TR photon(s) p.e. absorption (10 keV)

Position/energy sensitive TR detection

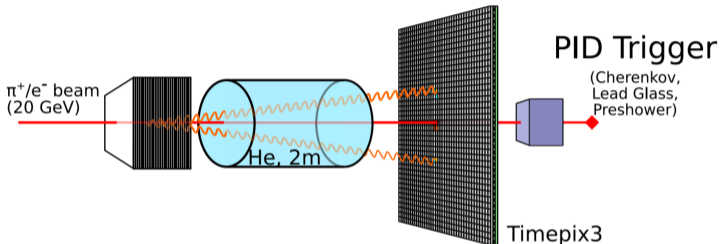


Figure: Transition Radiation Detector prototype with Timepix3
(Dachs F et al. 2020 NIMA 958 162037)

High granularity detector on some distance is able to register hits of a beam particle and TR photon events independently

Timepix3 for transition radiation

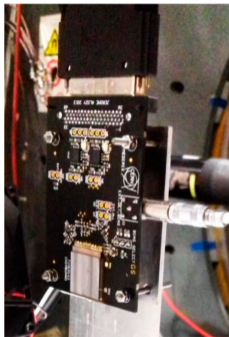
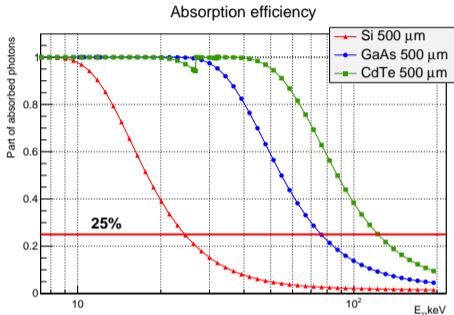


Figure: GaAs:Cr-Timepix3 on Katherine readout in the TRD prototype

Timepix3 for TR PID specs:

- > Independent energy measurement and timing in each pixel
- > 55 μm pitch \Rightarrow
Angular resolution $\sigma_{\theta} \sim 0.01$ mrad
- > Different sensors – 500 μm Si and 500 μm GaAs

Some thoughts about semiconductor sensor materials for X-rays detection



Material	Z	$K_{\alpha 1}$ [keV]	$K_{\alpha 2}$ [keV]	$d_{\alpha 1}$ [μm]	$d_{\alpha 2}$ [μm]	η [%]
Si	14	1.74	1.74	11.86	11.86	4.1
Ga	31	9.25	9.22	40.62	40.28	50.5
As	33	10.54	10.50	15.62	15.47	56.6
Cd	48	23.17	22.98	113.20	110.75	83.6
Te	52	27.47	27.20	59.32	57.85	87.3

Si

Is very technological to work with and has low fluorescent yield,
BUT is quite transparent for X-rays >25 keV

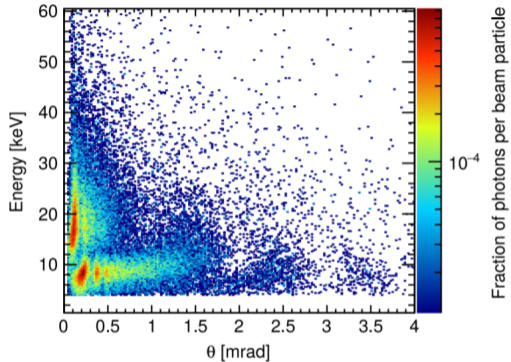
CdTe

Has very good X-rays absorption efficiency and can be up to 2 mm thick, **BUT** has strong fluorescence (and fluo photons can go far)

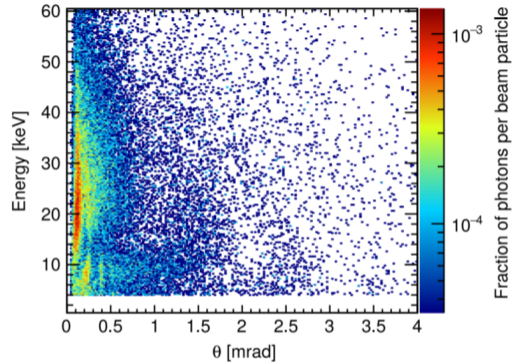
GaAs

Has good balance between efficiency and fluorescence. Can be up to 1 mm thick.
Is an optimal choice for X-rays of 10–60 keV

Silicon vs. GaAs



(a) Energy over angle of TR measured with a Si sensor.



(b) Energy over angle of TR measured with a GaAs sensor.

Figure: Energy-angle spectra. 20 GeV electron beam. Radiator of 30 Mylar foils (Dachs F et al. 2020 NIMA 958 162037)

What GaAs:Cr really is?

Pure GaAs: low resistivity, low electron lifetime

GaAs, Cr-compensated: high resistivity, medium electron lifetime

High resistivity bulk

No junctions, constant electric field, no need for sophisticated mobility models

Charge collection and induced signal

Limited carrier lifetime \Rightarrow CCE $<$ 100%

$\mu_h \ll \mu_e \Rightarrow$ holes don't really contribute

Charge sharing

Carrier diffusion and fluorescence may affect pixelated detector resolution

Charge carrier tracking algorithm

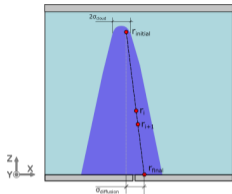


Figure: Modelling scheme

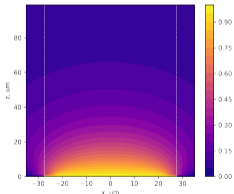


Figure: Weight potential near pixel

- 1 Generate initial (photo-e travel) and final (diffusion) position
- 2 On each step:
 - reduce charge (account for lifetime)
$$q_{i+1} = q_i \exp - \frac{(z_i - z_{i+1})d}{\mu\tau U_{bias}}$$
 - add fraction to induced signal
$$\Delta Q = q_i (V(\vec{r}_{i+1}) - V(\vec{r}_i))$$
- 3 Sum all contributions, add noise, apply threshold
- 4 CHEATING: add «interpixel smearing» and rescale energy

Modelling results

Measured spectra, Am-241

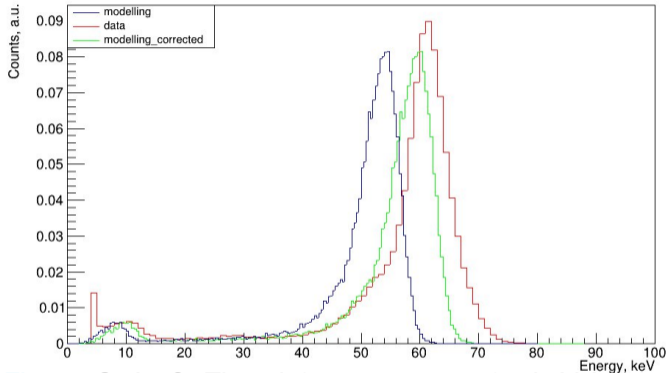


Figure: GaAs:Cr-Timepix3 response on 59.5 keV Am-241 line

Can't really simulate measured energy without proper FE electronics model :(

Cluster type breakdown

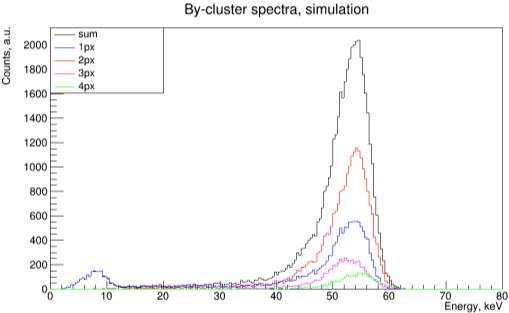


Figure: Am-241, simulation

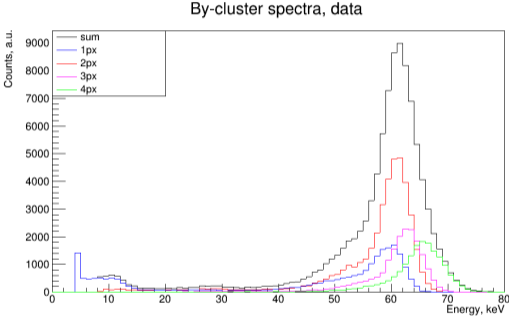


Figure: Am-241, data



Current status and what's next



Figure: A cat meme to illustrate current situation with the project

Thank you!

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